Supporting Information

Matrix-dependent high-contrast photochromism in Eu-doped M₃MgSi₂O₈ (M = Ca, Sr, Ba)

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Fig. S1. Crystal structure of a) Ca₃MgSi₂O₈, Sr₃MgSi₂O₈¹ and b) Ba₃MgSi₂O₈²



Fig. S2. XPS spectra of CMS, SMS and BMS samples doped with 0.1% Eu.



Fig. S3. Diffuse reflectance spectra of CMS doped with 0.01% Eu and 0% or 7.5% boron before (dashed lines) and after irradiation with 250 nm (solid lines).



Fig. S4. Comparison of the experimental (black curves) Eu L₃-edge EXAFS spectra $\chi(k)k^2$ and their Fourier transforms (FTs) with three calculated EXAFS spectra, corresponding to europium atoms placed at (a,b) Sr1 (brown curves), Sr2 (red curves), and Sr3 (orange curves) crystallographic sites in monoclinic Sr₃MgSi₂O₈⁻¹ and (c,d) Ca1 (brown curves), Ca2 (red curves), and Ca3 (orange curves) crystallographic sites in monoclinic sites in monoclinic Ca₃MgSi₂O₈.³



Fig. S5. Diffuse reflectance spectra of SMS doped with 0.1% Eu before irradiation, after irradiation with 250 nm for 5 min and after optical bleaching with 500 nm for 5 min. Insets: changes in the absorption intensity after a sequence of irradiation and bleaching; photographs of SMS doped with 0.1% Eu a) after irradiation of the right side with 250 nm and b) after bleaching with 500 nm for 5 min.



Fig. S6. EPR spectra of CMS, SMS and BMS samples with different concentrations of Eu²⁺ ions; acquisition settings: 10 mW microwave power, 0.4 mT modulation amplitude.



Fig. S7. EPR spectra of CMS samples with different Eu concentrations before and after irradiation with 250 nm.



Fig.S8. Simplified mechanism of photochromic effect in Eu-doped M₃MgSi₂O₈.

References

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